

**Notic of References Cited**Application/Control No.  
09/820,933Applicant(s)/Patent Under  
Reexamination  
MAKINO, HIDEYOExaminer  
Hai C PhamArt Unit  
2861

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	L	US-			
	M	US-			

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**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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